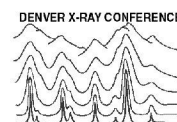


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[Table of
Contents](#)

[View
Document](#)

CONTENTS

I. XRF DETECTORS AND XRF INSTRUMENTATION

Solid-State Room-Temperature Energy Dispersive X-Ray Detectors. 1
Andrzej J. Dabrowski

Preliminary Study of the Behavior of HPCe Detectors with Ion Implanted Contacts in the Ultralow-Energy X-Ray Region. 23
M. Slapa, J. Chwaszczewska, J. Jurkowski,
A. Latuszynski, G. C. Huth, and A. J. Dabrowski

Performance of Room-Temperature X-Ray Detectors Made from Mercuric Iodide (HgI₂) Platelets 31
J. B. Barton, A. J. Dabrowski, J. S. Iwaczyk,
J. H. Kusmiss, G. Ricker, J. Vallerga, A. Warren,
M. R. Squillante, S. Lis, and G. Entine

The Gas Proportional Scintillation Counter as a Room Temperature Detector for Energy Dispersive X-Ray Fluorescence Analysis. 39
C. A. N. Conde, L. F. Requicha Ferreira and
A. J. de Campos

Performance Characteristics of a High Resolution Si(Li) Detector Using a Time Variant Amplifier and a Pulsed Source of X-Rays 45
M. A. Short and T. G. Gleason

X-Ray Tubes for Energy Dispersive XRF Spectrometry 49
Brian Skillicorn

Toroidal Monochromators in Hybrid XRF System Improve Effectiveness of EDXRF Ten Fold 59
Thomas C. Furnas, Jr., Gordon S. Kuntz, and
Richard E. Furnas

II. XRF METHODS: PRACTICAL, MATHEMATICAL

The Use of Polarized X-Rays for Improved Detection Limits in Energy Dispersive X-Ray Spectrometry.	63
Richard W. Ryon, John D. Zahrt, Peter Wobrauschek, and Hannes Aiginger	
X-Ray Fluorescence of Intermediate- to High-Atomic- Number Elements Using Polarized X Rays	75
R. B. Strittmatter	
Examples of Analysis from an Integrated X-Ray Fluorescence Analysis System Using NRLXRF	81
B. E. Artz and M. J. Rokosz	
A Modular ADC/Microcomputer System for Energy Dispersive X-Ray Spectroscopy	85
D. Hale, T. Satterfield, D. Blankenship, and J. C. Russ	
Volatilization of Sulfur in Fusion Techniques for Preparation of Discs for X-Ray Fluorescence Analysis	91
James W. Baker	
Techniques for the Preparation of Lithium Tetraborate Fused Single and Multielement Standards	95
Kent I. Mahan and Donald E. Leyden	

III. XRF APPLICATIONS: MINERAL AND GEOLOGICAL

The Use of EDXRF for Liquids in a Uranium-Vanadium Solvent Extraction Process	103
Rocky A. Smith	
A Resin-Loaded Paper X-Ray Fluorescence Method for Determining Uranium in Phosphate Materials	107
Benjamin W. Haynes, Jerome Zabronsky, and David L. Neylan	
The X-Ray Analysis of Uranium Ores for Iron Sulfide Minerals	113
A. J. Durbetaki, R. H. Carlson and T. F. Quail	
A Statistical Comparison of Data Obtained from Pressed Disk and Fused Bead Preparation Techniques for Geological Samples	117
Randall H. Dow	

Trace and Minor Element Analysis of Obsidian from the San Francisco Volcanic Field Using X-Ray Fluorescence.	121
Suzanne C. Sanders, John D. Zahrt, and Graydon Bell	
Quantitative Determination of Ga, Zn, Cu, Ni, Mn, and Cr by X-Ray Fluorescence in Laterites and Bauxites Using Two Evaluation Methods	127
Hasso Schorin	
A Combined Dilution and Line-Overlap Coefficient Solution for the Determination of Rare Earths in Monazite Concentrates.	133
T. K. Smith	
Feasibility Study for On-Stream X-Ray Analysis of Barite.	139
Yury M. Gurvich	
IV. XRF APPLICATIONS: METALS, CATALYSTS, OILS	
"Standard-Background" Method of X-Ray Spectral Analysis for Quality Control of Noble Metals in Alumina- Based Automobile Exhaust Catalysts	145
Yury M. Gurvich	
Some Elemental Determinations of Catalytic Materials Using a Thin-Film Internal Standard Technique by Radioisotope Excited X-Ray Fluorescence.	151
W. C. Parker and J. J. LaBrecque	
Energy Dispersive X-Ray Measurements for Cesium and Silver in Zeolite Ion-Exchange Columns.	157
H. A. Vincent and M. E. Patton	
Direct Analysis of Plutonium Metal for Gallium, Iron and Nickel by Energy Dispersive X-Ray Spectrometry.	163
H. L. Bramlet and J. H. Doyle	
The Analysis of Copper Alloys by Chem-X, Low Power WDX Multichannel Spectrometer	169
J. Lucas-Tooth, B. W. Adamson, and Y. M. Gurvich	
Energy Dispersive XRF Analysis of Lubricating Oil Additives with Secondary Target Excitation and the EXACT Fundamental Parameters Program	173
Kenneth C. Stehr	

- The Analysis of Oil Additives Using Fundamental
Influence Coefficients. 177
Mrs. H. M. West

V. XRF ENVIRONMENTAL APPLICATIONS

- The Measurement of Low Concentrations of Organic and
Inorganic Gaseous Contaminants in Occupational
Environments by X-Ray Spectrometry (XRS). 181
N. G. West, C. J. Purnell, R. H. Brown, and
E. Withers
- The Application of X-Ray Fluorescence and Diffraction
to the Characterization of Environmental
Assessment Samples 189
Albert C. Censullo and Frank E. Briden
- Accurate PIXE Analysis of Thin Samples, Aerosol Loaded
Filters and Surface Layers of Thick Samples. 195
U. Wätjen and F.-W. Richter
- Energy Dispersive Analysis of Actinides, Lanthanides,
and Other Elements in Soil and Sediment Samples 201
G. R. Laurer, J. Furfaro, M. Carlos, W. Lei,
R. Ballard, and T. J. Kneip
- X-Ray Fluorescence Analysis of Welding Fume Particles 209
Thomas P. Carsey

VI. XRD SEARCH/MATCH PROCEDURES AND AUTOMATION

- A New Computer Algorithm for Qualitative X-Ray Powder
Diffraction Analysis 213
T. C. Huang and W. Parrish
- A Versatile Minicomputer X-Ray Search/Match System 221
W. Parrish, G. L. Ayers and T. C. Huang
- Automatically Correcting for Specimen Displacement
Error During XRD Search/Match Identification 231
Walter N. Schreiner and Ronald Jenkins
- X-Ray Diffraction Phase Analysis Using Microcomputers 237
T. M. Hare, J. C. Russ, and M. J. Lanzo

A Second Generation Automated Powder Diffractometer Control System.	245
Robert L. Snyder, Camden R. Hubbard, and Nicolas C. Panagiotopoulos	
Application of the Modified Snyder's Program for the Data Processing of an Automated X-Ray Powder Diffractometer.	261
G. Platbrood, J. M. Quitin, and H. Barten	
INDEX, A Program to Reconcile Powder Diffractograms	267
Tommy Hom, Ron Jenkins, and Joshua Ladell	
IDENT - A Versatile Microfile-Based System for Fast Interactive XRPD Phase Analysis	273
Barbara A. Jobst and Herbert E. Göbel	

VII. XRD METHODS AND INSTRUMENTATION

Complete Quantitative Analysis Using Both X-Ray Fluorescence and X-Ray Diffraction	283
M. F. Garbaskas and R. P. Goehner	
Calibration of the Diffractometer at Low Values of Two Theta	289
R. Jenkins, T. Hom, C. Villamizar, and W. N. Schreiner	
Sample Preparation and Methodology for X-Ray Quanti- tative Analysis of Thin Aerosol Layers Deposited on Glass Fiber and Membrane Filters.	295
Briant L. Davis and L. Ronald Johnson	
Differential X-Ray Diffraction by Wavelength Variation: A Preliminary Investigation	301
M. C. Nichols, D. K. Smith, and Quintin Johnson	
X-Ray Diffraction Quantitative Analysis Using Intensity Ratios and External Standards	309
Raymond P. Goehner	
A Guinier Diffractometer with a Scanning Position Sensitive Detector	315
Herbert E. Göbel	
Observation of an X-Ray Beam of 10 Microradian Divergence Without Using Any Collimator	325
K. Das Gupta	

VIII. XRD APPLICATIONS

X-Ray Residual Stress Mapping in Industrial Materials by Energy Dispersive Diffractometry.	329
G. J. Bechtoldt, R. C. Placious, W. J. Boettinger, and M. Kuriyama	
Stress Measurement and Precision Diffraction Angles on Large Grained Specimens.	339
Charles S. Barrett	
Determination of Residual Stresses in Austenite and Martensite in Case-Hardened Steels by the $\text{Sin}^2\psi$ Method	343
Chongmin Kim	
X-Ray Characteristics and Applications of Layered Synthetic Microstructures.	355
J. V. Gilfrich, D. J. Nagel, N. G. Loter, and T. W. Barbee, Jr.	
The Use of Energy Dispersive Diffractometry to Measure the Thickness of Metal and Glass Thin Films.	365
Glen A. Stone	
Application of Automated X-Ray Diffraction to Alteration Mineral Zoning Studies	373
H. Salek, H. A. Vincent, and L. Thorpe	
The Application of X-Ray Diffraction for Glass Batch Homogeneity Determination	379
H. S. Kim and C. I. Cohen	
X-Ray Diffraction and Fluorescence in the Analysis of Pharmaceutical Excipients	383
A. J. Durbetaki and T. F. Quail	
Corrections to Volume 24	389
Author Index	391
Subject Index	393